EMI Common Mode Choke Automotive Grade AWCU Series





Overview

An EMI common mode choke (CMC) for power lines is a passive component specifically designed to suppress electromagnetic interference (EMI) in power supply circuits

A full series of common mode choke is designed for excellent noise attenuation with compact sizing for use in wide range of applications. Both standard series and custom designs are available.

Benefits

- 1. Automotive signal Line Common Mode Filter
- 2. Automotive CAN Bus Systems
- 3. Designed according the IEEE802.3 and IEC6228-3 standard
- 4. Operating temperature range −50°C ~ 150°C

Applications

- 1. Automotive CAN Bus Systems
- 2. EMI solutions for charger
- 3. LVDS
- 4. Networking

Product Information

Series	Size Code (JIS/EIA)	Impedance(Ω)
AWCU	2012/0805 3216/1206	30 ~ 6500
	3325/1210 4532/1812	

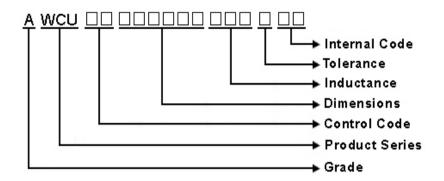






AEC-Q200

- 1 Scope: This specification applies to AWCU Wire Wound Common Mode Choke Coil
- 2 Part Numbering:



3 Rating:

Operating Temperature: -50° C $\sim 150^{\circ}$ C

(Including self - temperature rise)

Storage Temperature: - 40°C ~ 125°C

(The storage temperature range is for after the assembly)

4 Marking:

No Marking

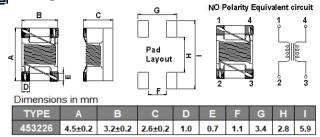
5 Standard Testing Condition

	In case of doubt	
Temperature	Ordinary Temperature(15 to 35℃)	20 to 30℃
Humidity	Ordinary Humidity(25 to 85% RH)	50 to 80 %RH



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6 Configuration and Dimensions and Unit Weight:



Net Weight (grms)

SIZE CODE	Net Weight (grms)
453226	0.157 (typ.)

7 Electrical Characteristics:

Part No.	L	Test Freq.	Ž	Z	Test Freq.	RDC	Irms	Rated Voltage	Withstanding Voltage	Insulation Resistance
	(uH)±30%		(Ω)Min.	(Ω)Typ.	(MHz)	(Ω)Max.	(mA)Max.	(Vdc)Max.	(Vdc)	(MΩ)Min.
AWCU00453226113 T2	11	100kHz,0.1V	300	600	10	0.6	250	50	125	10
AWCU00453226223 T2	22	100kHz,0.1V	500	1200	10	1	200	50	125	10
AWCU00453226513 _□ T2	51	100kHz,0.1V	1000	2800	10	1	200	50	125	10
AWCU00453226104□T2	100	100kHz,0.1V	2000	5800	10	2	150	50	125	10

NOTE: □-tolerance T=±30% / X=+50%-30%

1. Operating temperature range - 5 0 $^{\circ}$ C ~ 1 5 0 $^{\circ}$ C(Including self - temperature rise)

2.RDC: SINGLE WIRE TEST VALUE

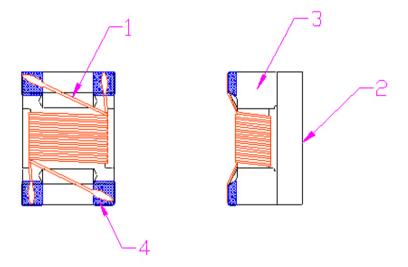
3.Irms for a 40°C temperature rise from 25°C ambient.

4.weight: 0.157(g) typ.



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8 AWCU00453226 Series 8.1 Construction:



8.2 Material List:

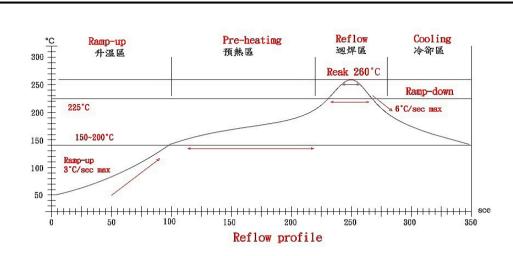
ITEM	PART	DESCRIPITON		
1	WIRE	Grade 180		
2	COVER SHEET	FERRITE CORE		
3	CORE	FERRITE CORE		
4	TERMINAL	Ag/Cu/Ni/Sn		





ı - ı . ıV	lechanical Performa		To at Mathead
4.4	Item	Specification	Test Method
-1-1	Board Flex	, ,	Test device shall be soldered on the substrate
		conditions must not damage	Substrate Dimension: 100x40x1.6mm
		the terminal electrode and the	
		ferrite.	Keeping Time: 60 sec
			45 - 45 - 45 - 45 - 45 - 45 - 45 - 45 -
-1-2	Terminal Strength		Appendix 1 Note(AEC-Q200-005):Force of 1.8 kg for 60
		terminal electrode and the	seconds.
		ferrite.	
-1-3	Solderability	The electrodes shall be at	Pre-heating: 150℃, 1min
		least 95% covered with new	Solder Composition: Sn/3.0Ag/0.5Cu
		solder coating.	Solder Temperature: 245±5℃
			Immersion Time: 4±1sec
	D		
-1-4	Resistance to	Appearance:No damage	Pre-heating: 150°C, 1min
	Soldering Heat	Inductance change shall	Solder Composition: Sn/Ag3.0/Cu0.5
		be within ±20%.	Solder Temperature: 260±5°C
			Immersion Time: 10±1sec
-1-5	Resistance to	There must be no change in	Inductors must withstand 6 minutes of alcohol or water.
	Solvents	appearance or obliteration of	
		marking.	
-1-6	Mechanical Shock	ŭ .	Pulse shape:Half-sine waveform
- 1-0	INICONALIICAI OHUUK	conditions must not damage	Pulse snape : Hair-sine waveform Impact acceleration : 100 g
		•	'
		the terminal electrode and the	
		ferrite.	Number of shocks: 18 shocks (3 shocks for each face)
			Orientation: Bottom, top, left, right, front and rear faces
117	Vibration	Annograpas:No damaga	Vibration waveform: Sine waveform
1-1-7	VIDIALIOIT	Appearance:No damage Inductance change shall be	
		within ±20%.	Vibration frequency: 10Hz~2000Hz
		Within ±20%.	Vibration acceleration: 5g
			Sweep rate: 0.764386otcave/minute
			Duration of test: 12 cycles each of 3 orientations
			20 minutes for each cycle
			Vibration axes: X, Y & Z
I-2 F	nvironmental Perfo	rmance	VISITATION AND CO. 74, 1 & 2
	nvironmental Perfo		Test Method
No	Item	rmance Specification	Test Method
No	Item High Temperature		Test Method Temperature: 150±3℃
No	Item		Test Method Temperature: 150±3℃ Time: 1000hrs
No 1-2-1	Item High Temperature Exposure (Storage)	Specification	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs
No 1-2-1	Item High Temperature Exposure (Storage) Low Temperature	Specification Appearance:No damage (for	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C
No 1-2-1	Item High Temperature Exposure (Storage)	Specification Appearance:No damage (for microscope of CASTOR MZ-4	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs
No 1-2-1	Item High Temperature Exposure (Storage) Low Temperature	Specification Appearance:No damage (for microscope of CASTOR MZ-4	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C
No I-2-1 I-2-2	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage)	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs
No I-2-1 I-2-2	Item High Temperature Exposure (Storage) Low Temperature	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C
No 1-2-1 1-2-2	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage)	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85%
No I-2-1 I-2-2	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage)	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs
No -2-1 -2-2	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs
No -2-1 -2-2 -2-3	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage)	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles
No -2-1 -2-2	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C
No -2-1 -2-2	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes
No -2-1	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs
No -2-1	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C
No -2-1	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current
No -2-1	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs
No -2-1 -2-2 -2-3 -2-4	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature: Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs
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No -2-1 -2-2 -2-3 -2-4	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second
No 1-2-1 1-2-2 1-2-3	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative
No 1-2-1 1-2-2 1-2-3 1-2-4	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge +/- for 1 time for the 2 test
No -2-1 -2-2 -2-3 -2-4	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge +/- for 1 time for the 2 test points.
No 1-2-1 1-2-2 1-2-3	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge Discharge: Discharge Test Mode: Air Discharge
No 1-2-1 1-2-2 1-2-3 1-2-4	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge Discharge level: ±12KV, ±16KV, ±25KV
No 1-2-1 1-2-2 1-2-3 1-2-4	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge +/- for 1 time for the 2 test points. Test Mode: Air Discharge Discharge level: ±12KV, ±16KV, ±25KV Discharge interval: <5 seconds
No 1-2-1 1-2-2 1-2-3 1-2-4	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature: Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge Discharge level: ±12KV, ±16KV, ±25KV Discharge interval: <5 seconds Polarity of the output voltage: Positive and negative
No 1-2-1 1-2-2 1-2-3	Item High Temperature Exposure (Storage) Low Temperature Exposure (Storage) Biased Humidity Temperature Cycling Operational Life	Specification Appearance:No damage (for microscope of CASTOR MZ-4 20X)Inductance change shall	Test Method Temperature: 150±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: -50±3°C Time: 1000hrs Measured after exposure in the room condition for 24hrs Temperature: 85±2°C Relative Humidity: 85% Time: 1000hrs Measured after exposure in the room condition for 24hrs Total cycles: 1000 cycles Temperature Cycling Test Conditions: -50 to +150 °C Soak Mode Condition: 30 minutes Measured after exposure in the room condition for 24hrs Temperature: 150±2°C Appliend Current: Rated Current Time: 1000± 24 hrs Measured after exposure in the room condition for 24hrs Test mode: Contact Discharge Discharge level: ±6KV, Discharge interval: 1 second Polarity of the output voltage: Positive and negative Number of discharge: Discharge +/- for 1 time for the 2 test points. Test Mode: Air Discharge Discharge level: ±12KV, ±16KV, ±25KV Discharge interval: <5 seconds





Lead-Free(LF)標準溫度分析範圍

Refer to J-STD-020C

管制項目	升温區	預熱區	迴焊區	Peak Temp	冷卻區
Item.	Ramp-up	Pre-heating	Reflow	теак тешр	Cooling
溫度範圍 Temp.scope	R.T ~ 150℃	150°C ~ 200°C	Above 217°C	260±5°C	Peak Temp.~150℃
標準時間 Time spec.	-	60 ~ 180 sec	60 ~ 150 sec	20 ~ 40 sec	-
實際時間 Time result	_	75 ~ 100 sec	90 ~ 120 sec	20 ~ 35 sec	-

NOTE:

- 1.Re-flow possible times : within 3 times
- 2. Nitrogen adopted is recommendes while in re-flow
- 3. Products can only be soldered with reflow



AEC-Q200

10 Packaging:

10.1 Packaging -Cover Tape

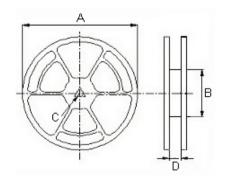
The force for tearing off cover tape is 10 to 100 grams in the arrow direction.



10.2 Packaging Quantity

TYPE	PCS/REEL
453226	2500

10.3 Reel Dimensions



Dimensions in mm

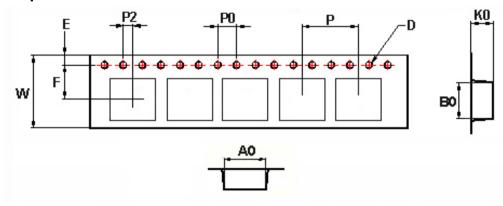
TYPE	Α	В	C	D
453226	330	100	13	13.4



AEC-Q200

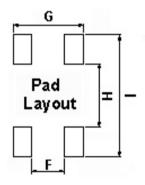
10 Packaging:

10.4 Tape Dimensions in mm



TYPE	A0	B0	K0	D	ш	Ŧ	W	P	P0	P2
453226	3.6	4.9	3.0	1.5	1.75	5.5	12	8	4	2

11 Recommended Land Pattern:



Dimensions in mm

TYPE	F	G	Н	Н
453226	1.1	3.4	2.8	5.9

12 Note:

- 1. Please make sure that your product has been evaluated and confirmed against your specifications when our product is mounted to your product.
- 2. Do not knock nor drop.
- 3. All the items and parameters in this product specification have been prescribed on the premise that our product is used for the purpose,under the condition and in the environment agreed upon between you and us. You are requested not to use our product deviating from such agreement.
- 4.The storage period is less than 12 months. Be sure to follow the storage conditions (Temperature: 5 to 40°C, Humidity: 10 to 75% RHor less).

If the storage period elapses, the soldering of the terminal electrodes may deteriorate.

- 5.Do not use or store in locations where there are conditions such as gas corrosion (salt, acid, alkali, etc.).
- 6. The moisture sensitivity level (MSL) of products is classified as level 1.



AEC-Q200

13 Graph:

